

# SEMITOP<sup>®</sup>E1

## Sixpack Open Emitter

## Engineering Sample SK25GD12T7ETE1

Target Data

#### Features\*

- Optimized design for superior thermal performance
- Low inductive design
- Press-Fit contact technology
- 1200V Generation 7 IGBT (T7)
  Robust and soft switching CAL4F
- diode technology
- Integrated NTC temperature sensorUL recognized file no. E 63 532

## **Typical Applications**

- Motor drives
- Servo drives
- Air conditioning
- Auxiliary Inverters

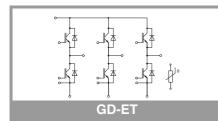
## • UPS

### Remarks

• Recommended  $T_{j,op}$ =-40 ...+150 °C

Absolute	Maximum Rating	S		
Symbol	Conditions		Values	Unit
Inverter -	IGBT			
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		1200	V
Ic	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	41	А
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	33	А
I <sub>C</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	47	А
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	38	А
I <sub>Cnom</sub>			25	А
I <sub>CRM</sub>			50	Α
V <sub>GES</sub>			-20 20	V
t <sub>psc</sub>	$V_{CC} = 800 V$ $V_{GE} \le 15 V$ $V_{CES} \le 1200 V$	T <sub>j</sub> = 175 °C	7	μs
Tj			-40 175	°C
Inverse -	Diode			
I <sub>F</sub>	λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	30	А
T <sub>j</sub> = 175 °C	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	24	А
I <sub>F</sub>	λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	35	А
	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	28	А
I <sub>FRM</sub>			50	А
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180	°, T <sub>j</sub> = 150 °C	100	А
Tj			-40 175	°C
Module	•			•
I <sub>t(RMS)</sub>	, ΔT <sub>terminal</sub> at PCB	joint = 30 K, per pin	30	А
T <sub>stg</sub>	module without TIM	Л	-40 125	°C
Visol	AC, sinusoidal, t =	1 min	2500	V

Characte	eristics							
Symbol	Conditions		min.	typ.	max.	Unit		
Inverter -	Inverter - IGBT							
V <sub>CE(sat)</sub>	I <sub>C</sub> = 25 A	T <sub>j</sub> = 25 °C		1.60	1.75	V		
	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 150 °C		1.82	1.96	V		
	chiplevel	T <sub>j</sub> = 175 °C		1.86	2.00	V		
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C		0.90	1.00	V		
	chiplevel	T <sub>j</sub> = 150 °C		0.75	0.83	V		
		T <sub>j</sub> = 175 °C		0.72	0.80	V		
r <sub>CE</sub>		T <sub>j</sub> = 25 °C		28	30	mΩ		
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		43	45	mΩ		
		T <sub>j</sub> = 175 °C		46	48	mΩ		
V <sub>GE(th)</sub>	$V_{GE} = V_{CE}, I_{C} = 0.53 \text{ mA}$		5.15	5.8	6.45	V		
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = 12$	200 V, T <sub>j</sub> = 25 °C			1	mA		
Cies	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		4.8		nF		
C <sub>oes</sub>		f = 1 MHz		0.0615		nF		
C <sub>res</sub>		f = 1 MHz		0.017		nF		
Q <sub>G</sub>	V <sub>GE</sub> = -15V+15V			354		nC		
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			0		Ω		





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#### Features\*

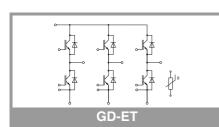
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- Auxiliary InvertersUPS

### Remarks

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Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -	IGBT					
t <sub>d(on)</sub>		T <sub>j</sub> = 25 °C		28		ns
		T <sub>j</sub> = 150 °C		30		ns
		T <sub>j</sub> = 175 °C		32		ns
t <sub>r</sub>		T <sub>j</sub> = 25 °C		23		
		T <sub>j</sub> = 150 °C		25		ns
	$V_{CC} = 600 V$	T <sub>j</sub> = 175 °C		26		ns
Eon	$I_{\rm C} = 25  {\rm A}$ $R_{\rm G on} = 6.2  {\Omega}$	T <sub>j</sub> = 25 °C		1.65		mJ
	$R_{G off} = 6.2 \Omega$	T <sub>j</sub> = 150 °C		2.42		mJ
	$V_{GE} = +15/-15 V$	T <sub>j</sub> = 175 °C		2.72		
t <sub>d(off)</sub>		T <sub>j</sub> = 25 °C		191		ns
	$\begin{array}{c} (T_{j} = 150 \ ^{\circ}\text{C}) \\ di/dt_{on} = 880 \ \text{A}/\mu\text{s} \\ di/dt_{off} = 210 \ \text{A}/\mu\text{s} \\ dv/dt = 5400 \ \text{V}/\mu\text{s} \end{array}$	T <sub>j</sub> = 150 °C		231		ns
		T <sub>j</sub> = 175 °C		251		ns
t <sub>f</sub>		T <sub>j</sub> = 25 °C		66		ns
		T <sub>j</sub> = 150 °C		101		ns
		T <sub>j</sub> = 175 °C		108		ns
E <sub>off</sub>		T <sub>j</sub> = 25 °C		2.04		mJ
	1	T <sub>j</sub> = 150 °C		2.71		mJ
		T <sub>j</sub> = 175 °C		3.09		mJ
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =0.	8 W/(mK)		1.32		K/W
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =2.	5 W/(mK)		1.06		K/W

## Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
Inverse -	Diode					
$V_F = V_{EC}$	I <sub>F</sub> = 25 A	T <sub>j</sub> = 25 °C		2.41	2.74	V
		T <sub>j</sub> = 150 °C		2.45	2.79	V
	chiplevel	T <sub>j</sub> = 175 °C		2.30	2.62	V
V <sub>F0</sub>		T <sub>j</sub> = 25 °C		1.30	1.50	V
	chiplevel	T <sub>j</sub> = 150 °C		0.90	1.10	V
		T <sub>j</sub> = 175 °C		0.82	0.98	V
r <sub>F</sub>		T <sub>j</sub> = 25 °C		44	50	mΩ
	chiplevel	T <sub>j</sub> = 150 °C		62	68	mΩ
		T <sub>j</sub> = 175 °C		59	66	mΩ
I <sub>RRM</sub>		T <sub>j</sub> = 25 °C		20		А
		T <sub>j</sub> = 150 °C		28		А
	I <sub>F</sub> = 25 A	T <sub>j</sub> = 175 °C		30		А
Q <sub>rr</sub>	$V_{GE} = +15/-15 V$	T <sub>j</sub> = 25 °C		1.41		μC
	V <sub>CC</sub> = 600 V	T <sub>j</sub> = 150 °C		3.71		μC
	$(T_j = 150 \text{ °C})$	T <sub>j</sub> = 175 °C		4.19		μC
Err	$di/dt_{off} = 1050 \text{ A/}\mu\text{s}$	T <sub>j</sub> = 25 °C		0.51		mJ
		T <sub>j</sub> = 150 °C		1.61		mJ
		T <sub>j</sub> = 175 °C		2.46		mJ
R <sub>th(j-s)</sub>	per Diode, $\lambda_{paste}=0$ .	8 W/(mK)		1.66		K/W
R <sub>th(j-s)</sub>	per Diode, $\lambda_{\text{paste}}$ =2.5 W/(mK)			1.29		K/W
Module						
L <sub>CE</sub>				30		nH
Ms	to heatsink		1.6		2.3	Nm
w				25		g



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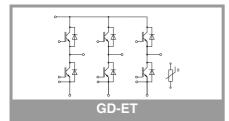
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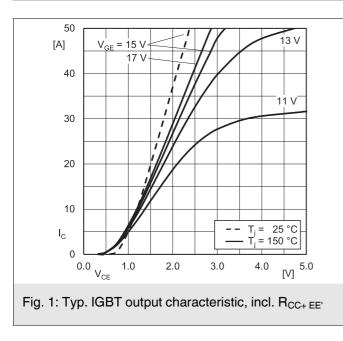
### Remarks

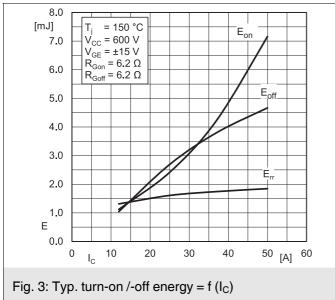
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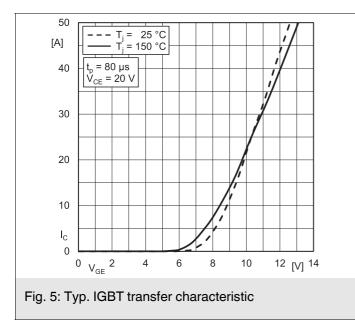


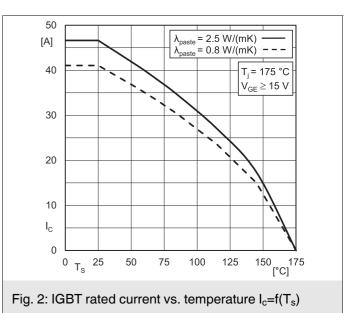
### Characteristics

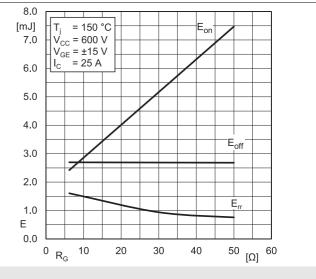
Symbol	Conditions	min.	typ.	max.	Unit	
Temperat	ure Sensor					
R <sub>100</sub>	T <sub>c</sub> =100°C (R <sub>25</sub> =5 kΩ)	493 ± 5%		Ω		
B <sub>25/85</sub>	R <sub>(T)</sub> =R <sub>25</sub> *exp[B <sub>25/85</sub> *(1/T-1/298)], T[K]	3420		К		

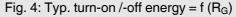












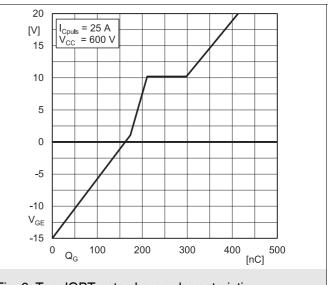
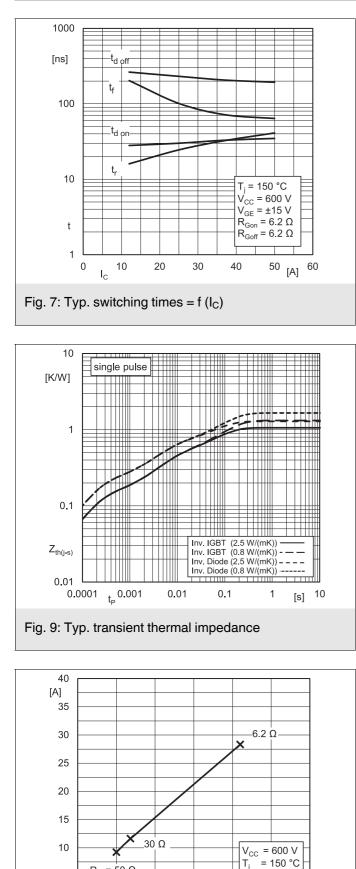
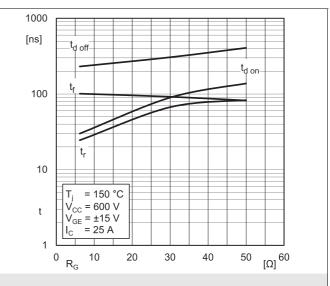
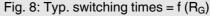
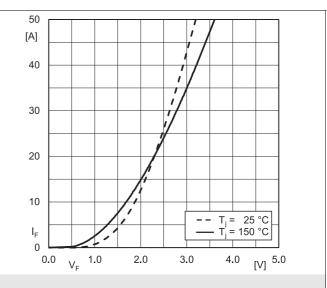


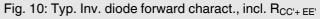
Fig. 6: Typ. IGBT gate charge characteristic

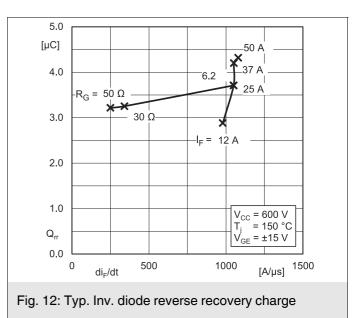














5

0

0

 $I_{RR}$ 

 $R_G = 50 \Omega$ 

di<sub>F</sub>/dt

500

Fig. 11: Typ. Inv. diode peak reverse recovery current

V<sub>GE</sub> = ±15 V

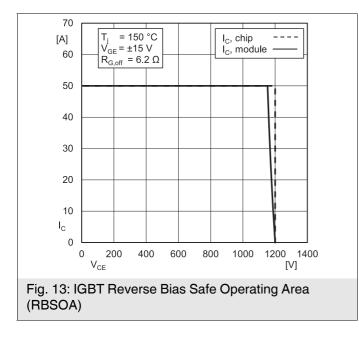
 $I_{F}$ 

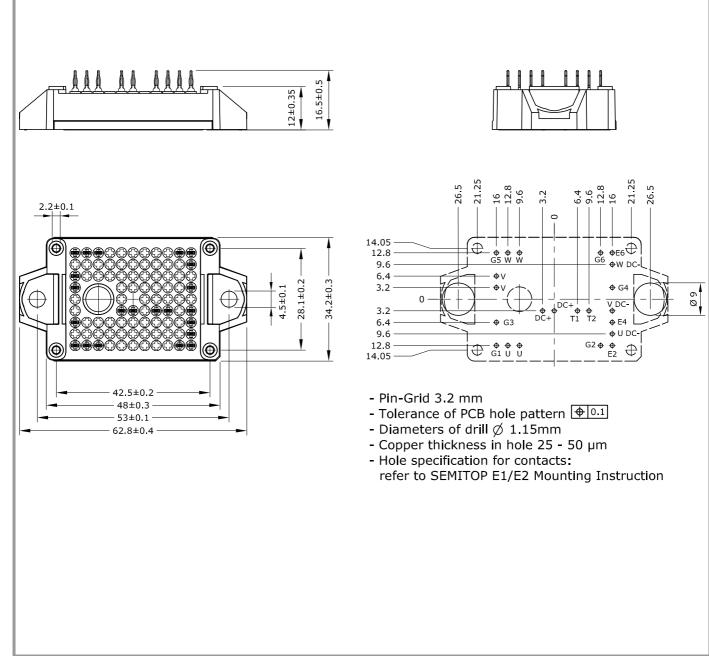
1000

= 25 A

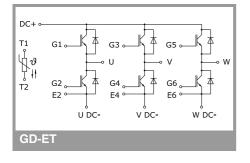
[A/µs]

1500





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Rev. 0.4 - 30.01.2021

This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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